



HIGH SPEED SILICON SWITCHING DIODES



SOD-80C (Mini MELF) SOD - 80C Mini MELF (LL- 34) SMD Glass Package

LL4148 LL4448

RoHS compliant

FEATURES:

- 1. Polarity: Cathode is indicated by a black band
- 2. Hermetically Sealed, Glass Silicon Diodes

ABSOLUTE MAXIMUM RATINGS ($T_a = 25 \degree C$)

PARAMETER		SYMBOL	VALUE	UNIT
Peak Repetitive Reverse Voltage		V_{RRM}	100	V
Reverse Voltage (Continuous)		V _R	75	V
Average Rectified Forward Current		I _{F(av)}	150	mA
Forward Current (DC)		I _F	200	mA
Repetitive Peak Forward Current		I _{FRM}	450	mA
Non Depetitive Deek Surge Current	t=1 ms	I _{FSM}	2000	mA
Non Repetitive Peak Surge Current	t=1 s	I _{FSM}	500	mA
Power Dissipation up to Tamb=25 °C		Б	500	mW
Derating factor		P _{tot}	2.85	mW/K
Operating and Storage Junction Temperature Range		T _j , T _{stg}	- 65 to +200	°C

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ELECTRICAL CHARACTERISTICS at T_a = 25 °C

PARAMETER		SYMBOL	TEST CONDITION	MIN	MAX	UNIT
	LL4148		I _F =10mA		1.0	
Forward Voltage	LL4448	V _F	I _F =5mA	0.62	0.72	V
	LL4440		I _F =100mA		1.0	
			V _R =20V		25	nA
Reverse Current		I _R	V _R =75V	_	5.0	μA
Reverse Guirent			V _R =20V, T _i =150° C	-	50	μA
	LL4448		V _R =20V, T _i =100° C		3.0	μA
Reverse Breakdown Voltage		V _{BR}	I _R =100mA	100	-	V
DYNAMIC CHARACTERISTICS						
Diode Capacitance		C _d	V _R =0V, f=1MHz	-	4.0	pF
Forward Recovery Voltage		Vfr	I _F =50mA, t _r =20ns	-	2.5	V
Reverse Recovery Time			I _F =10mA to I _R =60mA,			
		trr	R_L =100 Ω , Measured	-	4.0	ns
			at I _R =1mA			



Typical Characteristic Curves

Figure 1. Reverse Voltage vs Reverse Current BV - 1.0 to $100 \mu \text{A}$ 160 Ta=25 °C **∑**¹⁵⁰ Reverse Voltage, V_R 140 130 110 1 2 3 5 10 20 30 50 100 Reverse Current, I_R [uA]

Figure 3. Forward Voltage vs Forward Current V_{F} - 1 to $100 \mu \text{A}$

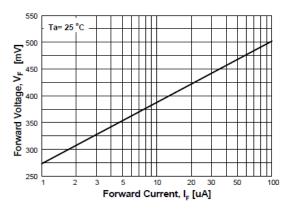
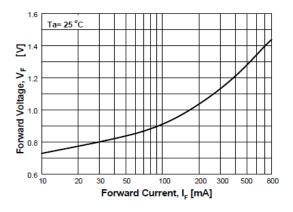
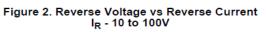


Figure 5. Forward Voltage vs Forward Current V_F - 10 to 800mA



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SUD

ISO 14001

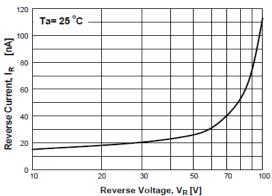


Figure 4. Forward Voltage vs Forward Current V_F - 0.1 to 10mA

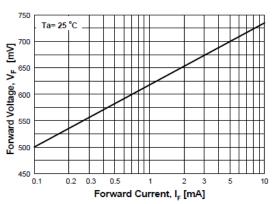
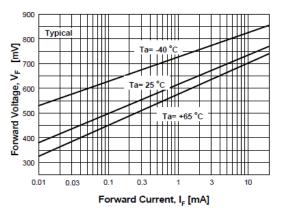


Figure 6. Forward Voltage vs Ambient Temperature V_F - 0.01 - 20mA (-40 to +65 Deg C)



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Typical Characteristic Curves Figure 7. Total Capacitance

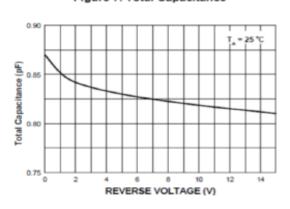


Figure 8. Reverse Recovery Time vs Reverse Recovery Current

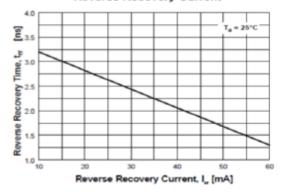


Figure 9. Average Rectified Current (I_{F(AV)}) versus Ambient Temperature (T_A)

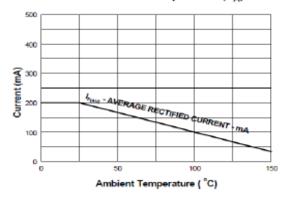
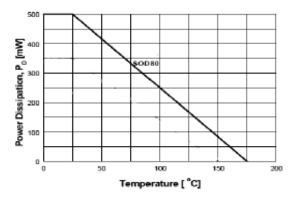


Figure 10. Power Derating Curve



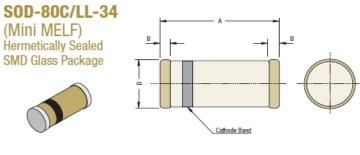
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Package Details



Dim	Min	Max
А	3.30	3.70
В	0.20	0.40
D	1.40	1.60
A 11 11		

All dimensions are in mm

Packaging Tape Specifications for SMD Packages

SMD Tape Specifications (8-12 mm) Device D1 D2 D3 T1 T2 T3 T4 S1 S2 S3 Max Max Max Dia

mm

mm

mm

mm

mm

mm

mm

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mm

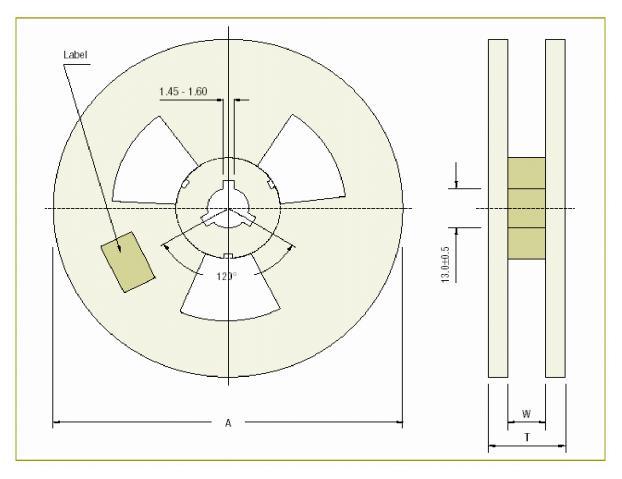
mm

mm





Reel Specifications for SMD Packages



Reel Specifications

Package	Tape	Reel Dia.	Devices	Inside	Reel
	Width		per Reel	Thickness	Thickness
		A - Max	and MOQ	W	T - Max
SOD-80C (Mini MELF)	8	180	2,500	8.4±2	14.4
	8	330	10,000	8.4±2	14.4





Recommended Product Storage Environment for Discrete Semiconductor Devices

This storage environment assumes that the Diodes and transistors are packed properly inside the original packing supplied by CDIL.

- · Temperature 5 °C to 30 °C
- · Humidity between 40 to 70 %RH
- · Air should be clean.
- · Avoid harmful gas or dust.
- $\cdot\,$ Avoid outdoor exposure or storage in areas subject to rain or water spraying .
- Avoid storage in areas subject to corrosive gas or dust. Product shall not be stored in areas exposed to direct sunlight.
- · Avoid rapid change of temperature.
- · Avoid condensation.
- · Mechanical stress such as vibration and impact shall be avoided.
- · The product shall not be placed directly on the floor.
- The product shall be stored on a plane area. They should not be turned upside down. They should not be placed against the wall.

Shelf Life of CDIL Products

The shelf life of products is the period from product manufacture to shipment to customers. The product can be unconditionally shipped within this period. The period is defined as 2 years.

If products are stored longer than the shelf life of 2 years the products shall be subjected to quality check as per CDIL quality procedure.

The products are further warranted for another one year after the date of shipment subject to the above conditions in CDIL original packing.

Floor Life of CDIL Products and MSL Level

When the products are opened from the original packing, the floor life will start. For this, the following JEDEC table may be referred:

JEDEC MSL Level				
Level	Time	Condition		
1	Unlimited	≤30 °C / 85% RH		
2	1 Year	≤30 °C / 60% RH		
2a	4 Weeks	≤30 °C / 60% RH		
3	168 Hours	≤30 °C / 60% RH		
4	72 Hours	≤30 °C / 60% RH		
5	48 Hours	≤30 °C / 60% RH		
5a	24 Hours	≤30 °C / 60% RH		
6	Time on Label(TOL)	≤30 °C / 60% RH		

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Customer Notes

Component Disposal Instructions

- 1. CDIL Semiconductor Devices are RoHS compliant, customers are requested to please dispose as per prevailing Environmental Legislation of their Country.
- 2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).

Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished in the Data Sheet and on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving/support appliances or systems. CDIL customers selling these products (either as individual Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

CDIL strives for continuous improvement and reserves the right to change the specifications of its products without prior notice.



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